TEMIC

TELEFUNKEN Semiconductors

S595T/S595TR

MOSMIC[®] For TV-Tuner Prestage With 5 V Supply Voltage

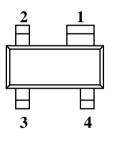
MOSMIC - MOS Monolithic Integrated Circuit

Applications

Low noise gain controlled input stages in UHF- and VHF-tuner with 5 V supply voltage.

Features

- Integrated gate protection diodes
- Low noise figure
- High gain
- Biasing network on chip



94 9279

S595T Marking: 595 Plastic case (SOT 143) 1 = Source; 2 = Drain; 3 = Gate 2; 4 = Gate 1

Absolute Maximum Ratings

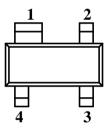
	RFC
AGCG2	
$$ $_{G1}$	D RF out
RF inS	C block
C block	94 9296

- Improved cross modulation at gain reduction
- High AGC-range

Electrostatic sensitive device.

Observe precautions for handling.

• SMD package



94 9278

S959TR Marking: 59 R Plastic case (SOT 143R) 1 = Source; 2 = Drain; 3 = Gate 2; 4 = Gate 1

Parameters	Symbol	Value	Unit
Drain source voltage	V _{DS}	8	V
Drain current	ID	20	mA
Gate 1/gate 2-source peak current	±I _{G1/G2SM}	10	mA
Gate 1/gate 2-source voltage	±V _{G1/G2SM}		V
Total power dissipation $T_{amb} \le 78^{\circ}C$	P _{tot}	160	mW
Channel temperature	T _{CH}	150	°C
Storage temperature range	T _{stg}	-55 to +150	°C

Maximum Thermal Resistance

Parameters	Symbol	Maximum	Unit
Channel ambient on glass fibre printed board $(25 \times 20 \times 1.5) \text{ mm}^3$ plated with 35 µm Cu	Reach	450	K/W

Electrical DC Characteristics

 $T_{amb} = 25^{\circ}C$

Parameters / Test Conditions	Symbol	Min.	Тур.	Max.	Unit
Gate 1-source breakdown voltage $\pm I_{G1S} = 10$ mA, $V_{G2S} = V_{DS} = 0$	±V _{(BR)G1SS}	7.5		9.5	v
Gate 2-source breakdown voltage $\pm I_{G2S} = 10$ mA, $V_{G1S} = V_{DS} = 0$	±V _{(BR)G2SS}	7.5		9.5	V
Gate 1-source cut-off current $\pm V_{G1S} = 5 \text{ V}, V_{G2S} = V_{DS} = 0$	±I _{G1SS}			50	μΑ
Gate 2-source cut-off current $\pm V_{G2S} = 5 \text{ V}, V_{G1S} = V_{DS} = 0$	±I _{G2SS}			20	nA
Drain current $V_{DS} = 5 V, V_{G1S} = 0, V_{G2S} = 4 V$	I _{DSS}	50		500	μΑ
Self-biased operating current $V_{DS} = 5 V, V_{G1S} = nc, V_{G2S} = 4 V$	I _{DSP}	8	12	16	mA
Gate 2-source cut-off voltage $V_{DS} = 5 \text{ V}, V_{G1S} = \text{nc}, I_D = 20 \mu\text{A}$	V _{G2S(OFF)}		1.0		v

Electrical AC Characteristics

 $V_{DS} = 5$ V, $V_{G2S} = 4$ V, f = 1 MHz, $T_{amb} = 25^{\circ}C$

Parameters / Test Conditions	Symbol	Min.	Тур.	Max.	Unit
Forward transadmittance	y _{21s}	25	30	35	mS
Gate 1 input capacitance	C _{issg1}		2.3	2.7	pF
Feedback capacitance	C _{rss}		25		fF
Output capacitance	Coss			1.1	pF
Power gain $g_S = 2 \text{ mS}, g_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$ $g_S = 3.3 \text{ mS}, g_L = 1 \text{ mS}, f = 800 \text{ MHz}$	$egin{array}{c} G_{ m ps} \ G_{ m ps} \end{array}$	17	28 20		dB dB
AGC range $V_{DS} = 5$ V, $V_{G2S} = 1$ to 4 V, f = 800 MHz	ΔG_{ps}	45			dB
Noise figure $g_S = 2 \text{ mS}, g_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$ $g_S = 3.3 \text{ mS}, g_L = 1 \text{ mS}, f = 800 \text{ MHz}$	F F		1 1.3		dB dB

Caution for Gate 1 switch-off mode:

No external DC-voltage on Gate 1 in active mode! Switch-off at Gate 1 with $V_{G1S} < 0.7$ V is feasible. Using open collector switching transistor (inside of PLL), insert 10 k Ω collector resistor.



Common Source S-Parameters $V_{DS} = 5 V$; $V_{G2S} = 4 V$

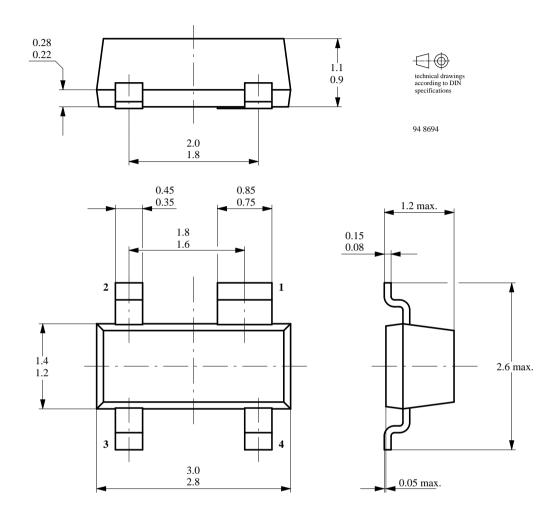
	S	S ₁₁ S ₂₁ S ₁₂		S ₂₁		12	S	S ₂₂	
f/MHz	LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG	
	dB	deg	dB	deg	dB	deg	dB	deg	
50	-0.02	-4.1	7.63	174.7	-63.74	88.0	-0.07	-1.8	
100	-0.04	-7.9	7.56	169.0	-57.38	85.8	-0.09	-3.4	
150	-0.11	-11.6	7.47	162.5	-53.95	82.9	-0.12	-5.3	
200	-0.19	-15.5	7.36	156.7	-51.68	80.5	-0.15	-6.9	
250	-0.30	-19.6	7.20	150.3	-50.05	78.0	-0.17	-8.8	
300	-0.39	-22.9	7.06	145.2	-48.69	76.6	-0.22	-10.4	
350	-0.54	-26.6	6.84	139.3	-47.82	74.8	-0.27	-11.8	
400	-0.67	-30.0	6.67	133.9	-47.15	73.6	-0.29	-13.6	
450	-0.82	-33.3	6.44	128.7	-46.66	72.8	-0.37	-15.1	
500	-0.98	-36.7	6.26	123.5	-46.39	72.1	-0.44	-16.8	
550	-1.14	-39.8	6.07	118.7	-46.33	72.0	-0.48	-18.3	
600	-1.30	-43.2	5.81	113.4	-46.34	74.4	-0.55	-19.8	
650	-1.44	-46.1	5.62	109.3	-46.14	76.3	-0.61	-21.1	
700	-1.58	-49.2	5.43	104.4	-46.17	78.6	-0.66	-22.5	
750	-1.74	-52.0	5.22	100.0	-46.48	81.7	-0.72	-24.2	
800	-1.91	-54.9	5.01	95.5	-46.65	87.0	-0.78	-25.5	
850	-2.02	-58.0	4.86	91.2	-46.62	93.4	-0.82	-27.0	
900	-2.16	-61.0	4.68	86.8	-46.43	102.1	-0.86	-28.7	
950	-2.28	-63.8	4.53	82.6	-45.77	110.0	-0.93	-30.0	
1000	-2.43	-66.6	4.29	78.4	-45.10	114.9	-1.01	-31.4	
1050	-2.57	-69.4	4.12	73.8	-44.59	119.4	-1.12	-32.7	
1100	-2.74	-72.4	3.93	69.9	-44.05	126.3	-1.18	-34.2	
1150	-2.81	-75.3	3.85	65.7	-43.14	132.1	-1.20	-35.8	
1200	-2.93	-78.0	3.74	62.0	-42.24	138.1	-1.23	-37.3	
1250	-3.06	-80.8	3.63	57.8	-41.21	143.1	-1.27	-38.7	
1300	-3.16	-83.8	3.47	53.4	-40.03	146.5	-1.39	-40.1	

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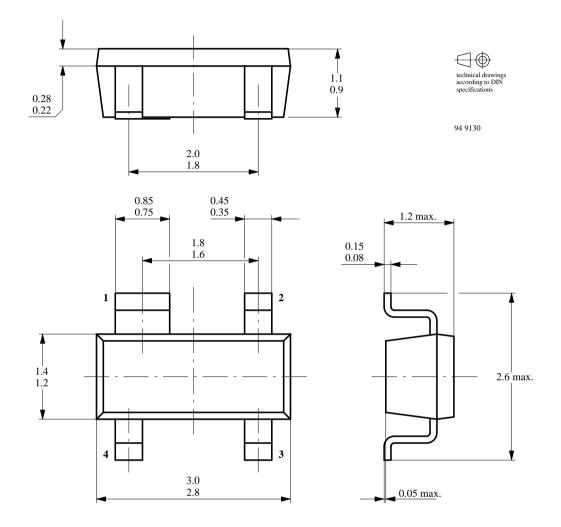
TELEFUNKEN Semiconductors

Dimensions of S595T in mm



S595T/S595TR

Dimensions of S595TR in mm



S595T/S595TR

Ozone Depleting Substances Policy Statement

It is the policy of TEMIC TELEFUNKEN microelectronic GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

TEMIC TELEFUNKEN microelectronic GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany Telephone: 49 (0)7131 67 2831, Fax Number: 49 (0)7131 67 2423